### INTEGRATED CIRCUITS

# DATA SHEET

# **MB2245**

16-bit transceivers with direction pins (3-State)

Product specification Supersedes data of 1993 Aug 18 IC23 Data Handbook





# 16-bit transceiver with direction pins (3-State)

**MB2245** 

#### **FEATURES**

- 16-bit bidirectional bus interface
- Power-up 3-State
- Multiple V<sub>CC</sub> and GND pins minimize switching noise
- 3-State buffers
- Output capability: +64 mA/-32mA
- Latch-up protection exceeds 500mA per Jedec Std 17
- ESD protection exceeds 2000 V per MIL STD 883 Method 3015 and 200V per Machine Model
- Inputs are disabled during 3-State mode

#### **DESCRIPTION**

The MB2245 high-performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive.

The MB2245 device is a 16-bit transceiver featuring non-inverting 3-State bus compatible outputs in both send and receive directions. The control function implementation minimizes external timing requirements. The device features two Output Enable (1OE, 2OE) inputs for easy cascading and two Direction (1DIR, 2DIR) inputs for direction control.

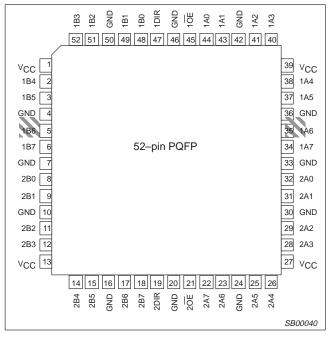
#### **QUICK REFERENCE DATA**

SYMBOL	PARAMETER	CONDITIONS T <sub>amb</sub> = 25°C; GND = 0V	TYPICAL	UNIT
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay nAx to nBx or nBx to nAx	$C_L = 50pF; V_{CC} = 5V$	3.2 3.1	ns
C <sub>IN</sub>	Input capacitance	$V_I = 0V \text{ or } V_{CC}$	4	pF
C <sub>I/O</sub>	I/O pin capacitance	V <sub>O</sub> = 0V or V <sub>CC</sub> ; 3-State	7	pF
I <sub>CCZ</sub>	Total supply current	Outputs disabled; V <sub>CC</sub> = 5.5V	65	μΑ

#### **ORDERING INFORMATION**

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER
52-pin plastic Quad Flat Pack	-40°C to +85°C	MB2245 BB	MB2245 BB	SOT379-1

#### **PIN CONFIGURATION**



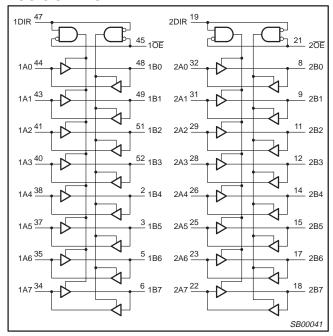
#### **PIN DESCRIPTION**

PIN NUMBER	SYMBOL	NAME AND FUNCTION
47, 19	1DIR, 2DIR	Direction control inputs (Active-High)
44, 43, 41, 40, 38, 37, 35, 34, 32, 31, 29, 28, 26, 25, 23, 22	1A0 – 1A7, 2A0 – 2A7	Data inputs/outputs (A side)
48, 49, 51, 52, 2, 3, 5, 6, 8, 9, 11, 12, 14, 15, 17, 18	1B0 – 1B7, 2B0 – 2B7	Data outputs/outputs (B side)
45, 21	1 <del>0E</del> , 2 <del>0E</del>	Output enable (Active-Low)
4, 7, 10, 16, 20, 24, 30, 33, 36, 42, 46, 50	GND	Ground (0V)
1, 13, 27, 39	V <sub>CC</sub>	Positive supply voltage

# 16-bit transceiver with direction pins (3-State)

MB2245

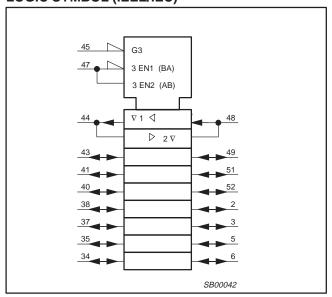
#### **LOGIC SYMBOL**

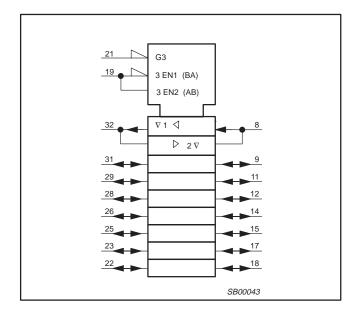


#### **FUNCTION TABLE**

INP	UTS	INPUTS/C	DUTPUTS
nOE	nDIR	nAx	nBx
L	L	A = B	Inputs
L	Н	Inputs	B = A
Н	Х	Z	Z

### LOGIC SYMBOL (IEEE/IEC)





# 16-bit transceiver with direction pins (3-State)

MB2245

#### **ABSOLUTE MAXIMUM RATINGS<sup>1, 2</sup>**

SYMBOL	PARAMETER	PARAMETER CONDITIONS					
V <sub>CC</sub>	DC supply voltage		-0.5 to +7.0	V			
I <sub>IK</sub>	DC input diode current	V <sub>1</sub> < 0	-18	mA			
VI	DC input voltage <sup>3</sup>		-1.2 to +7.0	V			
l <sub>OK</sub>	DC output diode current	V <sub>O</sub> < 0	-50	mA			
V <sub>OUT</sub>	DC output voltage <sup>3</sup>	output in Off or High state	-0.5 to +5.5	V			
I <sub>OUT</sub>	DC output current	output in Low state	128	mA			
T <sub>stg</sub>	Storage temperature range		-65 to 150	°C			

#### **NOTES**

#### **RECOMMENDED OPERATING CONDITIONS**

SYMBOL	PARAMETER	LIM	UNIT	
		Min	Max	
V <sub>CC</sub>	DC supply voltage	4.5	5.5	V
VI	Input voltage	0	V <sub>CC</sub>	V
V <sub>IH</sub>	High-level input voltage	2.0		V
V <sub>IL</sub>	Low-level Input voltage		0.8	V
Іон	High-level output current		-32	mA
I <sub>OL</sub>	Low-level output current		64	mA
Δt/Δν	Input transition rise or fall rate	0	10	ns/V
T <sub>amb</sub>	Operating free-air temperature range	-40	+85	°C

Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the
device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to
absolute-maximum-rated conditions for extended periods may affect device reliability.

<sup>2.</sup> The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C.

<sup>3.</sup> The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

# 16-bit transceiver with direction pins (3-State)

MB2245

#### DC ELECTRICAL CHARACTERISTICS

					LIMITS			
SYMBOL	PARAMETER	TEST CONDITIONS	Ta	<sub>mb</sub> = +25	S°C	T <sub>amb</sub> =	UNIT	
			Min	Тур	Max	Min	Max	
V <sub>IK</sub>	Input clamp voltage	V <sub>CC</sub> = 4.5V; I <sub>IK</sub> = -18mA		-0.9	-1.2		-1.2	V
		$V_{CC} = 4.5V$ ; $I_{OH} = -3mA$ ; $V_I = V_{IL}$ or $V_{IH}$	2.5	2.9		2.5		V
V <sub>OH</sub>	High-level output voltage	$V_{CC} = 5.0V$ ; $I_{OH} = -3mA$ ; $V_I = V_{IL}$ or $V_{IH}$	3.0	3.4		3.0		V
		$V_{CC} = 4.5V$ ; $I_{OH} = -32mA$ ; $V_I = V_{IL}$ or $V_{IH}$	2.0	2.4		2.0		V
V <sub>OL</sub>	Low-level output voltage	$V_{CC} = 4.5V$ ; $I_{OL} = 64mA$ ; $V_I = V_{IL}$ or $V_{IH}$		0.42	0.55		0.55	V
I <sub>I</sub>	Input leakage current	V <sub>CC</sub> = 5.5V; V <sub>I</sub> = GND or 5.5V		±0.01	±1.0		±1.0	μΑ
I <sub>OFF</sub>	Power-off leakage current	$V_{CC} = 0.0V$ ; $V_O$ or $V_I \le 4.5V$		±5.0	±100		±100	μΑ
I <sub>PU</sub> /I <sub>PU</sub>	Power-up/down 3-State output current	$V_{\underline{CC}}$ = 2.0V; $V_{\underline{O}}$ = 0.5V; $V_{\underline{I}}$ = GND or $V_{\underline{CC}}$ ; $V_{\underline{OE}}$ = $V_{\underline{CC}}$		±5.0	±50		±50	μА
I <sub>OZH</sub>	3-State output High current	$V_{CC} = 5.5V; V_{O} = 2.7V; V_{I} = V_{IL} \text{ or } V_{IH}$		5.0	50		50	μΑ
I <sub>OZL</sub>	3-State output Low current	$V_{CC} = 5.5V; V_O = 0.5V; V_I = V_{IL} \text{ or } V_{IH}$		-5.0	-50		-50	μΑ
I <sub>CEX</sub>	Output high leakage current	$V_{CC} = 5.5V$ ; $V_{O} = 5.5V$ ; $V_{I} = GND$ or $V_{CC}$		5.0	50		50	μΑ
I <sub>O</sub>	Output current <sup>1</sup>	V <sub>CC</sub> = 5.5V; V <sub>O</sub> = 2.5V	-50	-70	-180	-50	-180	mA
I <sub>CCH</sub>		$V_{CC}$ = 5.5V; Outputs High, $V_{I}$ = GND or $V_{CC}$		65	250		250	μΑ
I <sub>CCL</sub>	Quiescent supply current	$V_{CC} = 5.5V$ ; Outputs Low, $V_I = GND$ or $V_{CC}$		48	60		60	mA
I <sub>CCZ</sub>		$V_{CC}$ = 5.5V; Outputs 3-State; $V_{I}$ = GND or $V_{CC}$		65	250		250	μА
Δl <sub>CC</sub>	Additional supply current per input pin <sup>2</sup>	Outputs enabled, one input at 3.4V, other inputs at $V_{CC}$ or GND; $V_{CC}$ = 5.5V		0.5	1.5		1.5	mA

#### NOTES:

- Not more than one output should be tested at a time, and the duration of the test should not exceed one second.
   This is the increase in supply current for each input at 3.4V.

#### **AC CHARACTERISTICS**

GND = 0V;  $t_R$  =  $t_F$  = 2.5ns;  $C_L$  = 50pF,  $R_L$  = 500 $\Omega$ 

					LIMIT	s		
SYMBOL	PARAMETER	WAVEFORM	T <sub>a</sub>	<sub>amb</sub> = +25° CC = +5.0°	C V	T <sub>amb</sub> = -40° V <sub>CC</sub> = +5.	°C to +85°C .0V ±0.5V	UNIT
			Min	Тур	Max	Min	Max	
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay nAx to nBx or nBx to nAx	1	1.2 1.2	3.2 3.1	4.5 4.5	1.2 1.2	5.1 5.1	ns
t <sub>PZH</sub> t <sub>PZL</sub>	Output enable time to High and Low level	2	2.1 2.4	3.8 4.7	5.2 6.1	2.1 2.4	5.8 7.1	ns
t <sub>PHZ</sub> t <sub>PLZ</sub>	Output disable time from High and Low level	2	2.1 2.1	4.5 4.0	5.8 5.3	2.1 2.1	6.4 5.9	ns

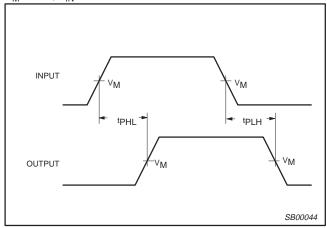
# 16-bit transceiver with direction pins (3-State)

MB2245

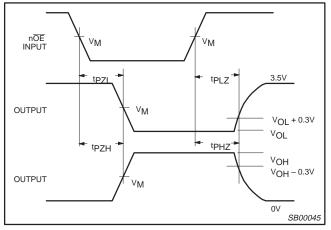
SB00010

#### **AC WAVEFORMS**

 $V_{M} = 1.5V, V_{IN} = GND \text{ to } 3.0V$ 

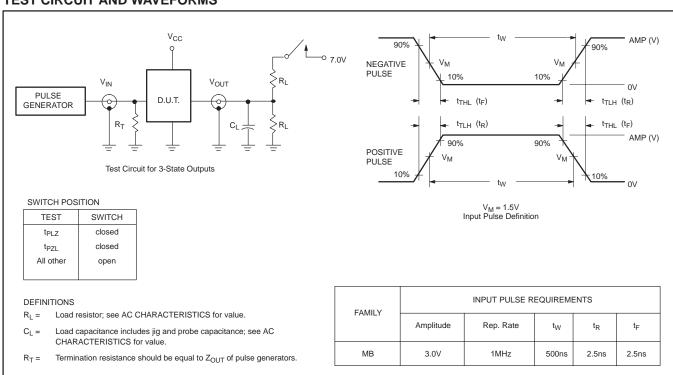


Waveform 1. Waveforms Showing the Input to Output Propagation Delays



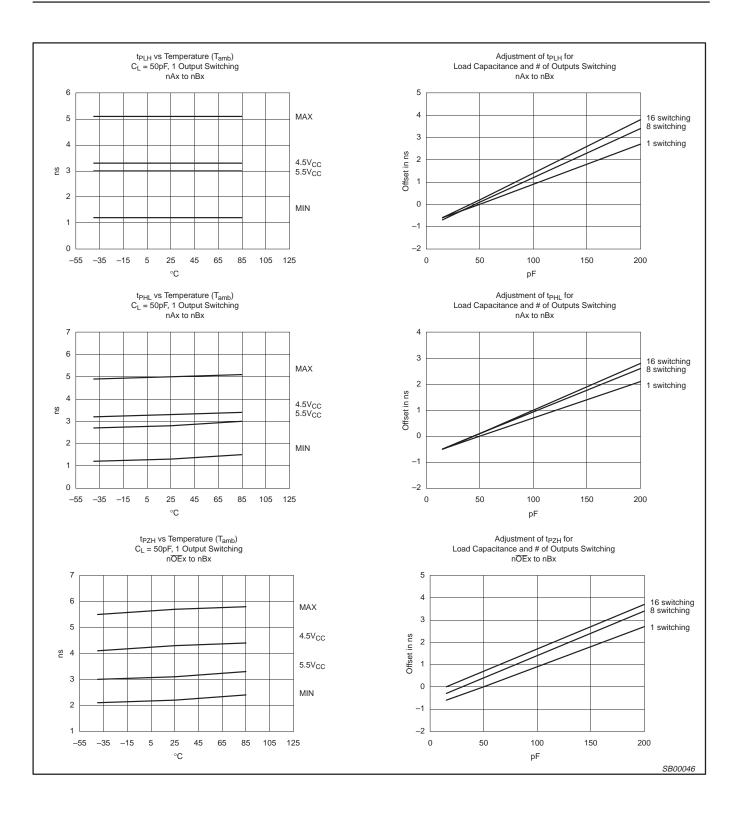
Waveform 2. Waveforms Showing the 3-State Output Enable and Disable Times

#### **TEST CIRCUIT AND WAVEFORMS**



# 16-bit transceiver with direction pins (3-State)

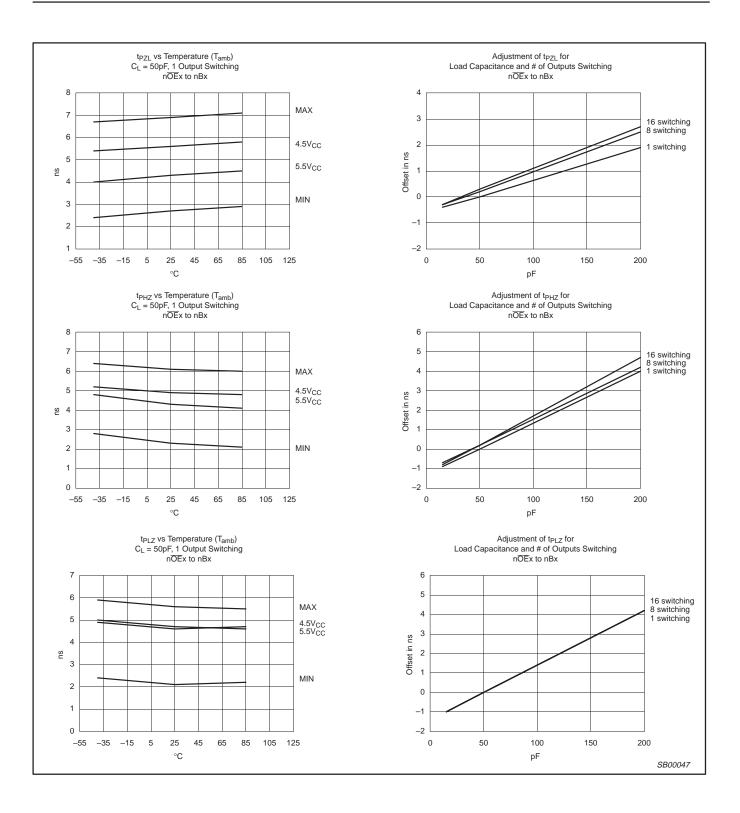
MB2245



1998 Jan 16 7

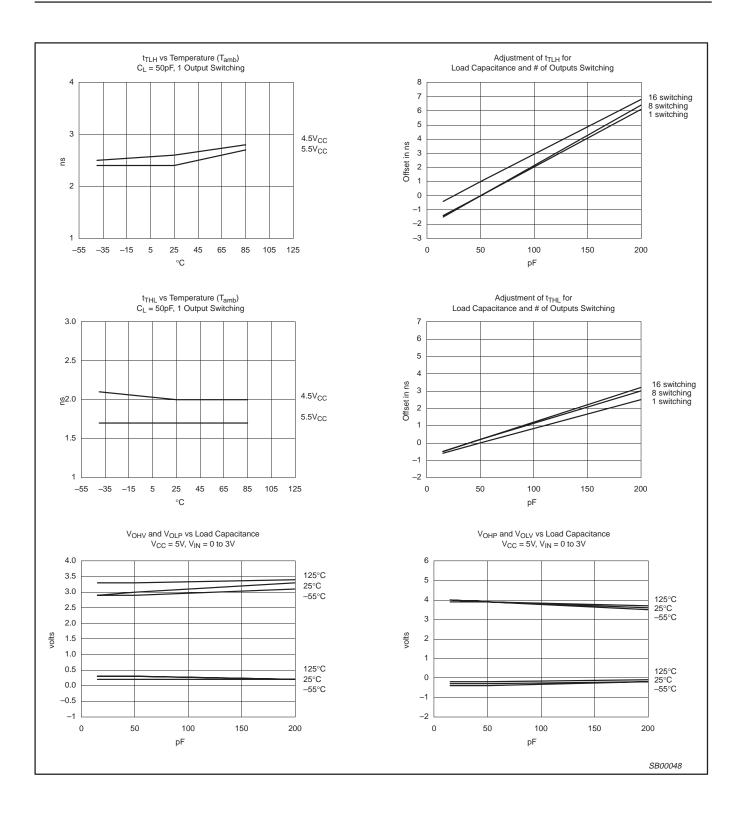
# 16-bit transceiver with direction pins (3-State)

### MB2245



# 16-bit transceiver with direction pins (3-State)

MB2245

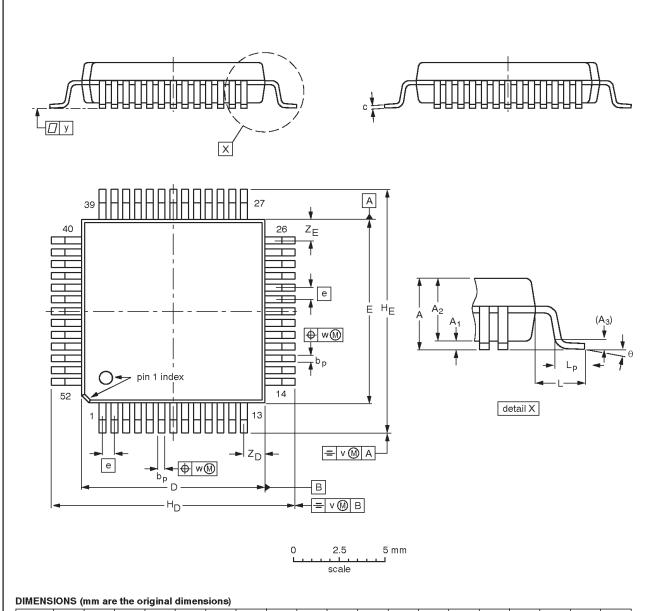


# 16-bit transceivers with direction pins (3-State)

MB2245

#### QFP52: plastic quad flat package; 52 leads (lead length 1.6 mm); body 10 x 10 x 2.0 mm

SOT379-1



UNIT	A max.	Α1	A <sub>2</sub>	Α3	bp	С	D <sup>(1)</sup>	E <sup>(1)</sup>	e	H <sub>D</sub>	HE	L	Lp	>	w	у	Z <sub>D</sub> <sup>(1)</sup>	Z <sub>E</sub> <sup>(1)</sup>	θ
mm	2.45	0.45 0.25	2.10 1.95	0.25	0.38 0.22	0.23 0.13	10.1 9.9	10.1 9.9	0.65	13.45 12.95	13.45 12.95	1.60	0.95 0.65	0.20	0.12	0.10	1.24 0.95	1.24 0.95	7° 0°

#### Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE
SOT379-1		MO-108			<del>-95-02-04-</del> 97-08-04

1998 Jan 16 10

# 16-bit transceivers with direction pins (3-State)

MB2245

**NOTES** 

### 16-bit transceivers with direction pins (3-State)

MB2245

#### Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make chages at any time without notice in order to improve design and supply the best possible product.
Product specification	Production	This data sheet contains final specifications. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.

<sup>[1]</sup> Please consult the most recently issued datasheet before initiating or completing a design.

#### Definitions

**Short-form specification** — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

**Application information** — Applications that are described herein for any of these products are for illustrative purposes only. Philips Semiconductors make no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

#### **Disclaimers**

**Life support** — These products are not designed for use in life support appliances, devices or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips Semiconductors customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips Semiconductors for any damages resulting from such application.

Right to make changes — Philips Semiconductors reserves the right to make changes, without notice, in the products, including circuits, standard cells, and/or software, described or contained herein in order to improve design and/or performance. Philips Semiconductors assumes no responsibility or liability for the use of any of these products, conveys no license or title under any patent, copyright, or mask work right to these products, and makes no representations or warranties that these products are free from patent, copyright, or mask work right infringement, unless otherwise specified.

Philips Semiconductors 811 East Arques Avenue P.O. Box 3409 Sunnyvale, California 94088–3409 Telephone 800-234-7381 © Copyright Philips Electronics North America Corporation 1998 All rights reserved. Printed in U.S.A.

print code Date of release: 05-96

Document order number: 9397-750-03511

Let's make things better.

Philips Semiconductors



